

Search Notes**Application/Control No.**

10/659,367

Examiner

Gary W. Counts

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
422	56, 57, 60, 87, 99	4/18/2006	GC
435	287.2	4/18/2006	GC
435	287.7	4/18/2006	GC
435	287.9	4/18/2006	GC
435	7.1	4/18/2006	GC
search	updated	2/5/2007	GC
search	updated	7/17/2007	GC
search	updated	12/20/2007	GC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm Inventors Search, East/West, and STN	4/17/2006	GC
Consulted Chris Chin and Bao Thuy Nguyen concerning possible art and search strategy	4/18/2007	GC
Consulted Long Le, concerning antecedent support in spec. and 112 issues concerning claim 20	4/18/2006	GC
Consulted Bao Thuy Nguyen concerning calibration zone location as recited in claim 22 and possible art	2/5/2007	GC
Consulted Long Le concerning combination of Good, Wei or Robinons and the recitation "wherein the amount of the analyte	2/5/2007	GC
present in the sample" does not limit the device	2/5/2007	GC
above search updated	2/5/2007	GC
above search updated	7/17/2007	GC

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/659,367	CHEN ET AL.	
Examiner	Gary W. Counts	Art Unit 1641	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner